Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/542,726	YOSHIDA ET AL.		
Examiner	Art Unit		
Francis T. Palo	3644		

	SEARCHED				
Class	Subclass	Date	Examiner		
47	65.9	12/26/2007	FP		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

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